# Memory ReRAM

# 8M (1024 K $\times$ 8) Bit SPI

# MB85AS8MT

#### **■** DESCRIPTION

MB85AS8MT is a ReRAM (Resistive Random Access Memory) chip in a configuration of 1,048,576 words  $\times$  8 bits, using the resistance-variable memory process and silicon gate CMOS process technologies for forming the nonvolatile memory cells.

MB85AS8MT adopts the Serial Peripheral Interface (SPI).

MB85AS8MT is able to retain data without using a back-up battery, as is needed for SRAM.

The memory cells used in the MB85AS8MT can be used for  $1 \times 10^6$  rewrite operations.

#### **■ FEATURES**

Bit configuration
 Serial Peripheral Interface
 SPI (Serial Peripheral Interface)

Correspondent to SPI mode 0 (0, 0) and mode 3 (1, 1)

Write buffer size : 256 bytesOperating frequency : 10 MHz (Max)

• Data endurance : 1 × 10<sup>6</sup> times / 4bytes\*

\*4 bytes are selected by A1 to A0.

Data retention : 10 years (+85 °C)
 Operating power supply voltage : 1.6 V to 3.6 V

• Operating power supply current : Write current 1.5 mA (Typ)

Read current 0.15 mA (Typ@5 MHz)

Standby current 60 μA (Typ) Sleep current 6 μA (Typ)

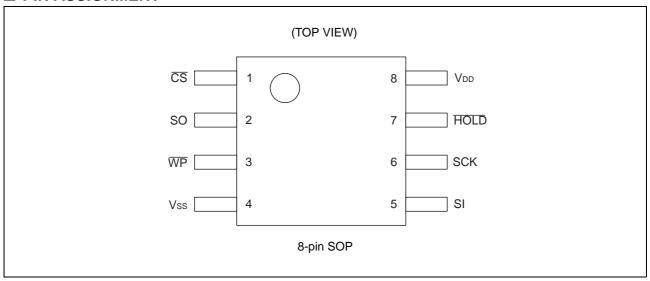
• Operation ambient temperature range : -40 °C to +85 °C

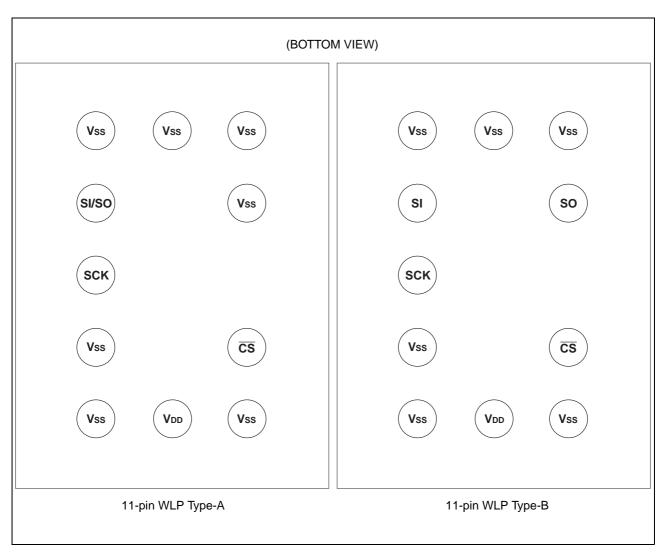
Package : 8-pin plastic SOP, 11-pin plastic WLP

RoHS compliant



## **■ PIN ASSIGNMENT**



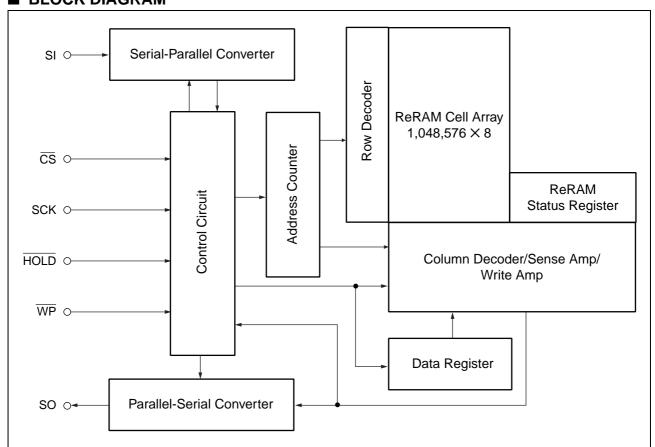


## **■ PIN FUNCTIONAL DESCRIPTIONS**

Pin No.	Pin Name	Functional description
1	<u>cs</u>	Chip Select pin This is an input pin to make chips select. When $\overline{CS}$ is "H" level, device is in deselect (standby) status and SO becomes High-Z. Inputs from other pins are ignored for this time. When $\overline{CS}$ is "L" level, device is in select (active) status. $\overline{CS}$ has to be "L" level before inputting op-code.
3	WP	Write Protect pin (available only for SOP package) This is a pin to control writing to a status register. The writing of status register (see "■ STATUS REGISTER") is protected in related with WP and WPEN. See "■ WRITING PROTECT" for detail.
7	HOLD	Hold pin (available only for SOP package) This pin is used to interrupt serial input/output without making chips deselect. When HOLD is "L" level, hold operation is activated, SO becomes High-Z, SCK and SI become do not care. While the hold operation, $\overline{\text{CS}}$ has to be retained "L" level.
6	SCK	Serial Clock pin This is a clock input pin to input/output serial data. SI is loaded synchronously to a rising edge, SO is output synchronously to a falling edge.
5	SI	Serial Data Input pin This is an input pin of serial data. This inputs op-code, address, and writing data.
2	SO	Serial Data Output pin This is an output pin of serial data. Reading data of ReRAM memory cell array and status register data are output. This is High-Z during standby.
8	V <sub>DD</sub>	Supply Voltage pin
4	Vss	Ground pin

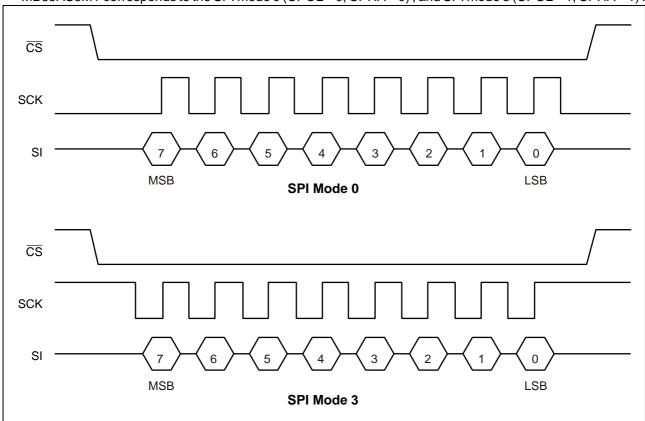
<sup>\*:</sup> Pin No. is for SOP package.

## **■ BLOCK DIAGRAM**



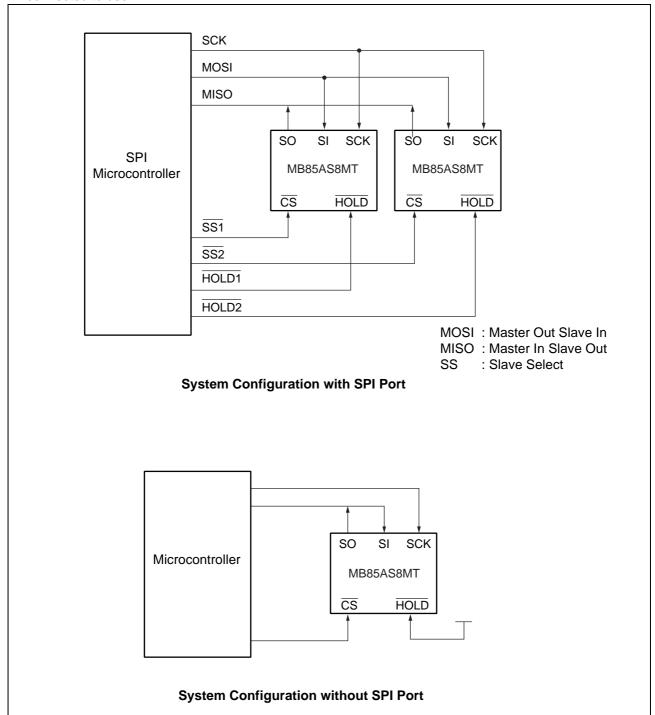
## ■ SPI MODE

MB85AS8MT corresponds to the SPI mode 0 (CPOL = 0, CPHA = 0), and SPI mode 3 (CPOL = 1, CPHA = 1).



## ■ SERIAL PERIPHERAL INTERFACE (SPI)

MB85AS8MT works as a slave of SPI. More than 2 devices can be connected by using microcontroller equipped with SPI port. By using a microcontroller not equipped with SPI port, SI and SO can be bus connected to use.



## **■ STATUS REGISTER**

Bit No.	Bit Name	Function		
7	WPEN	Status Register Write Protect This is a bit composed of nonvolatile memories (ReRAM). WPEN protects writing to a status register (refer to "■ WRITING PROTECT") relating with WP input. Writing with the WRSR command and reading with the RDSR command are possible.		
6 to 4	_	Not Used Bits These are bits composed of volatile memories, writing with the WRSR command is possible. These bits are not used but they are read with the RDSR command. Initial value is "000".		
3	BP1	Block Protect This is a bit composed of nonvolatile memory. This defines size of write		
2 BP0		protect block for the WRITE command (refer to "■ BLOCK PROTECT Writing with the WRSR command and reading with the RDSR command are possible.		
1	WEL	Write Enable Latch This indicates ReRAM Array and status register are writable. The WREN command is for setting, and the WRDI command is for resetting. With the RDSR command, reading is possible but writing is not possible with the WRSR command. WEL is reset after the following operations.  After power ON.		
		The rising edge of $\overline{\text{CS}}$ after WRDI command recognition.  The end of writing process after WRSR command recognition.  The end of writing process after WRITE command recognition.		
0	WIP	Write In Progress This indicates ReRAM Array and status register are in writing process. During this writing process, any commands except RDSR will not be executed (refer to "2. WIP polling"). With the RDSR command, reading is possible but writing is not possible with the WRSR command.		

## ■ OP-CODE

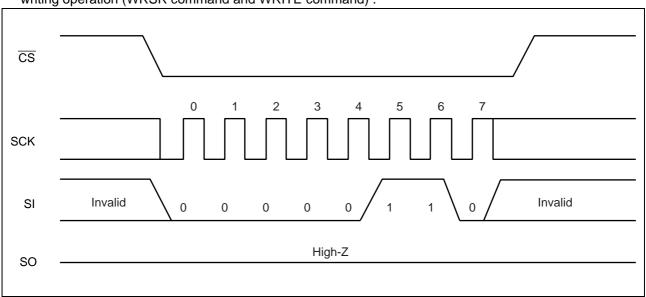
MB85AS8MT accepts 10 kinds of command specified in op-code. Op-code is a code composed of 8 bits shown in the table below. Do not input invalid codes other than those codes. If  $\overline{\text{CS}}$  is risen while inputting op-code, the command are not performed.

Name	Description	Op-code
WREN	Set Write Enable Latch	0000 0110в
WRDI	Reset Write Enable Latch	0000 0100в
RDSR	Read Status Register	0000 0101в
WRSR	Write Status Register	0000 0001в
READ	Read Memory Code	0000 0011в
WRITE	Write Memory Code	0000 0010в
RDID	Read Device ID	1001 1111в
RDUID	Read Device ID and Unique ID	1000 0011в
SLEEP	Enter Sleep Mode (Power Down Mode)	1011 1001в
PWDN	Enter Sieep wode (Fower Down wode)	1110 0010в

#### **■ COMMAND**

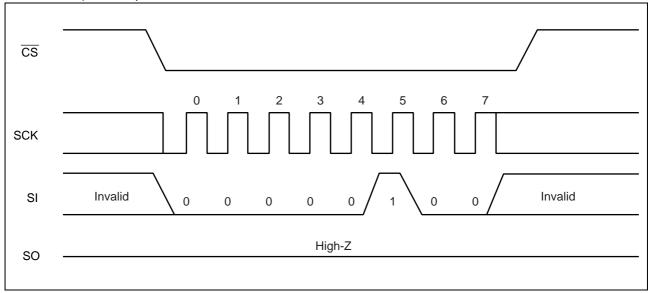
#### • WREN

The WREN command sets WEL (Write Enable Latch) . WEL has to be set with the WREN command before writing operation (WRSR command and WRITE command) .



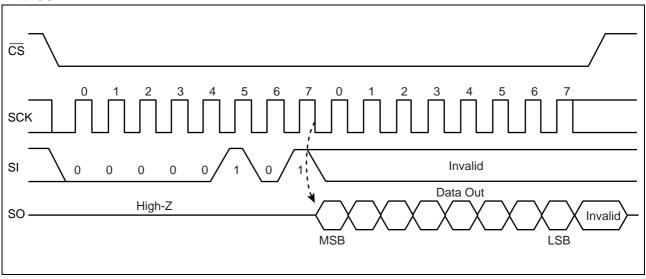
#### • WRDI

The WRDI command resets WEL (Write Enable Latch) . Writing operation (WRSR command and WRITE command) are not performed when WEL is reset.



#### • RDSR

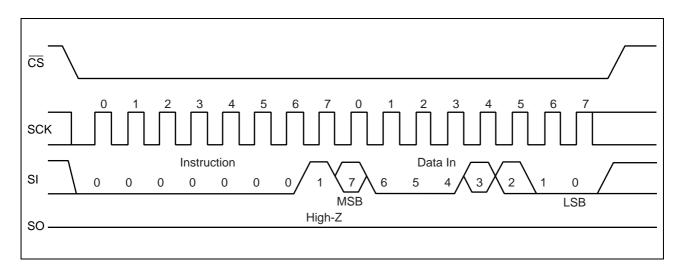
The RDSR command reads status register data. After op-code of RDSR is input to SI, 8-cycle clock is input to SCK. The SI value is invalid for this time. SO is output synchronously to a falling edge of SCK. In the RDSR command, repeated reading of status register is enabled by sending SCK continuously before rising of  $\overline{\text{CS}}$ .



#### • WRSR

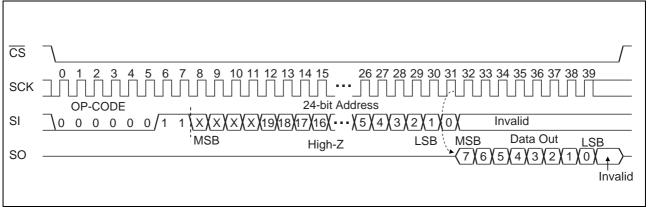
The WRSR command writes data to the nonvolatile memory bit of status register. After performing WRSR op-code to a SI pin, 8 bits writing data is input. WEL (Write Enable Latch) is not able to be written with WRSR command. A SI value correspondent to bit 1 is ignored. Bit 0 of the status register cannot be written. The SI value corresponding to bit 0 is ignored. WP signal level shall be fixed before performing WRSR command, and do not change the WP signal level until the end of command sequence.

After rising edge of  $\overline{CS}$ , MB85AS8MT starts writing operation to nonvolatile register and set WIP bit in status register to "1". After this writing operation has finished, reset this WIP bit from "1" to "0". Although the RDSR command is executable for WIP polling during this writing process, any other commands will not be performed.



#### • READ

The READ command reads ReRAM memory cell array data. Arbitrary 24 bits address and op-code of READ are input to SI. The 4-bit upper address bit is invalid. Then, 8-cycle clock is input to SCK. SO is output synchronously to the falling edge of SCK. While reading, the SI value is invalid. When  $\overline{\text{CS}}$  is risen, the READ command is completed, but keeps on reading with automatic address increment which is enabled by continuously sending clocks to SCK in unit of 8 cycles before  $\overline{\text{CS}}$  rising. When it reaches the most significant address, it rolls over to the starting address, and reading cycle keeps on infinitely.

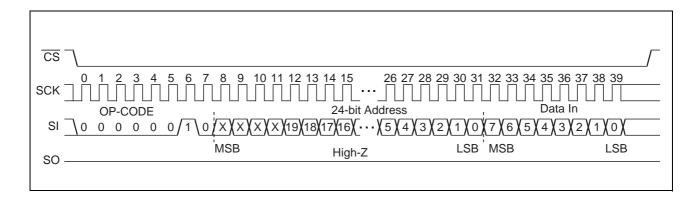


#### • WRITE

The WRITE command writes data to ReRAM memory cell array. WRITE op-code, arbitrary 24 bits of address and 8 bits of writing data are input to SI. The 4-bit upper address bit is invalid.

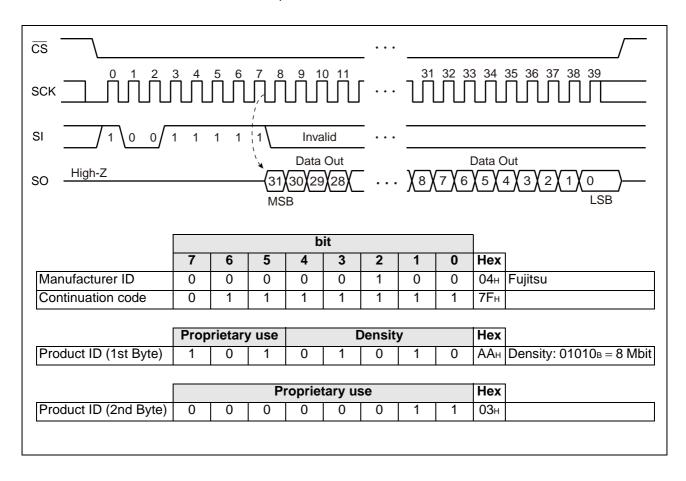
During the  $\overline{CS}$  is low, input writing data are temporary saved in the data register. The maximum writing data size is 256 bytes during this  $\overline{CS}$  = low period. If the input writing data are more than 8 bits, it is possible to continue writing with automatic address increment. When it reaches the most significant address, it rolls over to the starting address, and writing cycle can be continued up to 256 bytes (which is the size of data register). Data exceed 256 bytes can not be written.

After rising edge of  $\overline{CS}$ , MB85AS8MT starts writing operation to nonvolatile memory and set WIP bit in status register to "1". After this writing operation has finished, reset this WIP bit from "1" to "0". Although the RDSR command is executable for WIP polling during this writing process, any other commands will not be performed.



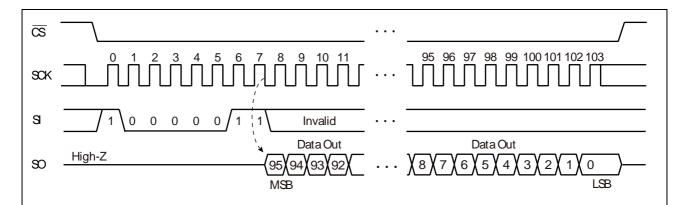
#### • RDID

The RDID command reads fixed Device ID. After performing RDID op-code to SI, 32-cycle clock is input to SCK. The SI value is invalid for this time. SO is output synchronously to a falling edge of SCK. The output is in order of Manufacturer ID (8bit)/Continuation code (8bit)/Product ID (1st Byte)/Product ID (2nd Byte). In the RDID command, SO holds the output state of the last bit in 32-bit Device ID until  $\overline{CS}$  is risen.



#### • RDUID

The RDUID command reads (common) Device ID and (each chip-specific) Unique ID. After performing RDUID op-code to SI, 96-cycle clock is input to SCK. The SI value is invalid for this time. SO is output synchronously to a falling edge of SCK. The output is in order of Manufacturer ID (8bit) / Continuation code (8bit) / Product ID (1st Byte) / Product ID (2nd Byte) as Device ID and Lot ID (40bit) / Wafer ID (8bit) / Chip ID (16bit) as Unique ID. In the RDUID command, SO holds the output state of the last bit in 96-bit Device ID and Unique ID until  $\overline{CS}$  is risen.

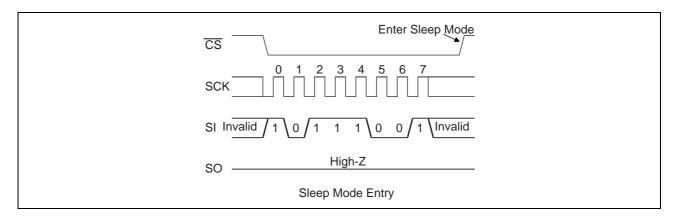


	Bits	Field	Value	Description
Device ID	[95:88]	Manufacture ID	04h	Fujitsu
Device ID	[87:80]	Continuation code	7Fh	
Device ID	[79:72]	Product ID	AAh	101b: Proprietary use 01010b: Density (8 Mbit)
Device ID	[71:64]	Product ID	03h	Proprietary use
Unique ID	[63:24]	Lot ID		-64 bit
Unique ID	[23:16]	Wafer ID		Unique ID
Unique ID	[15:0]	Chip ID		7

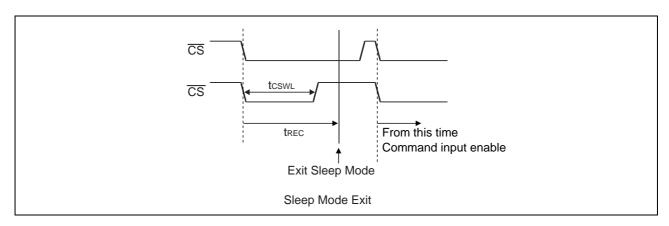
#### SLEEP/PWDN

The SLEEP/PWDN command shifts the LSI to a low power mode called "SLEEP mode" ("Power Down mode"). The transition to the SLEEP mode (Power Down mode) is carried out at the rising edge of  $\overline{CS}$  after operation code in the SLEEP (PWDN) command. However, when at least one SCK clock is inputted before the rising edge of  $\overline{CS}$  after operation code in the SLEEP (PWDN) command, this SLEEP (PWDN) command is canceled.

After the SLEEP mode (Power Down mode) transition, SCK and SI inputs are ignored and SO changes to a High-Z state.



Returning to a normal operation from the SLEEP mode (Power Down mode) is carried out after tree time from the falling edge of  $\overline{CS}$  (see the figure below). It is possible to return  $\overline{CS}$  to H level before tree time. However, it is prohibited to bring down  $\overline{CS}$  to L level again during tree period.



#### ■ WRITING OPERATION OF NONVOLATILE MEMORY

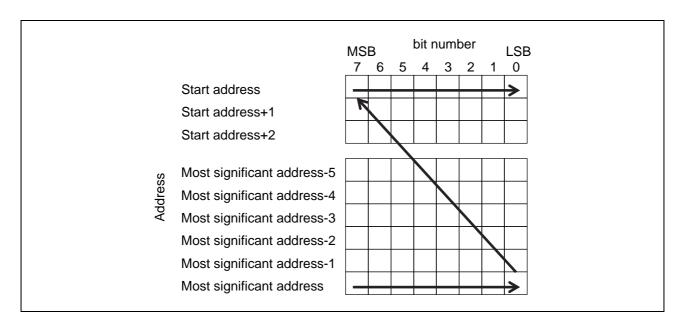
Each input data is not written to the nonvolatile memory by unit of byte right after its data input. Multiple bytes up to maximum 256 bytes are temporarily saved to the data register. After the command input is finished and rising edge of  $\overline{CS}$ , start writing operation from this data register to the nonvolatile memory.

#### 1. Address counter control

In case of memory access by WRITE and READ commands, after the end of op-code and address input, it is possible to keep on accessing (= reading or writing) with automatic address increment which is enabled by continuously sending clocks to SCK in unit of 8 cycles while  $\overline{CS}$  is low level. However, for the WRITE command, continuous writing is restricted by the limit of buffer size in the data register.

When it reaches the most significant address, it rolls over to the starting address, and this automatic address increment will be continued by the address counter control.

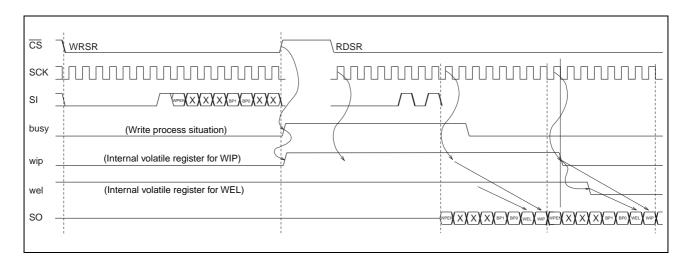
Over write protection to the nonvolatile memory is enabled by BP0 and BP1 bits in status register. When the memory address exceed it from write protected block to unprotected block by address counter control, write to the unprotected block only. Similarly, when memory address exceed it from unprotected block to protected block, does not write to the protected block.



#### 2. WIP polling

After the last writing data was input, writing to the nonvolatile memory needs two waiting time from the rising edge of  $\overline{CS}$ . This two time becomes larger than a minimum clock cycle. Production variation and operating condition are considered, and this maximum two value is defined. In the usual operation, this two time is shorter than the maximum value. Therefore, MB85AS8MT supports WIP polling to improve memory access by optimizing the waiting time.

After starting the data writing to nonvolatile memory, MB85AS8MT sets "1" to a volatile register related to the WIP bit in status register. After finished the writing operation, reset this WIP bit from "1" to "0". Although the usual commands are not executable during this writing process, only the RDSR command is acceptable. RDSR command outputs the value of status register to SO. It is possible to confirm if the internal writing operation to nonvolatile memory is finished or not, by checking the corresponding bit to WIP in output data from SO.



RDSR command also outputs the WPEN, BP1 and BP0 of status register to SO. In the polling after WRSR command, MB85AS8MT outputs the WPEN, BP1 and BP0 data which is set before the writing to nonvolatile memory is completed. On the other hand for WEL and WIP, MB85AS8MT outputs (WEL,WIP)=2'b11 when the writing to nonvolatile memory is not completed. When it is competed, outputs (WEL,WIP)=2'b00.

If continuously sending clocks to SCK during  $\overline{CS}$  = low, it is also possible to keep on outputting WPEN to WIP bits in status register in unit of 8 cycles since 17th clock. In case the WIP polling is applied, WIP and WEL bits in status register output to SO by RDSR command are updated regularly.

Figure shows the example of RDSR command input with continuously sending clocks over 17 during  $\overline{CS}$  = low, before the writing process of WRSR command is finished.

#### **■ BLOCK PROTECT**

Writing protect block for WRITE command is configured by the value of BP0 and BP1 in the status register.

BP1	BP0	Protected Block
0	0	None
0	1	C0000н to FFFFFн (upper 1/4)
1	0	80000н to FFFFFн (upper 1/2)
1	1	00000н to FFFFFн (all)

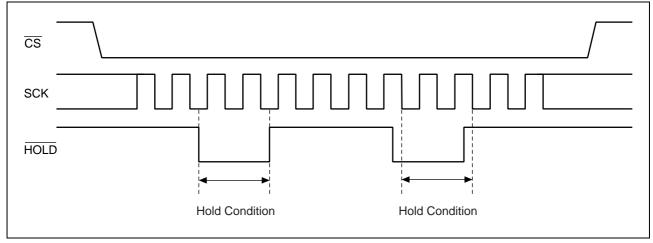
#### **■ WRITING PROTECT**

Writing operation of the WRITE command and the WRSR command are protected with the value of WEL, WPEN,  $\overline{WP}$  as shown in the table. In WLP package,  $\overline{WP}$  is fixed to "1".

WEL	WPEN	WP	Protected Blocks	Unprotected Blocks	Status Register
0	Х	Х	Protected	Protected	Protected
1	0	Х	Protected	Unprotected	Unprotected
1	1	0	Protected	Unprotected	Protected
1	1	1	Protected	Unprotected	Unprotected

## ■ HOLD OPERATION (available only for SOP package)

Hold status is retained without aborting a command if HOLD is "L" level while  $\overline{CS}$  is "L" level. The timing for starting and ending hold status depends on the SCK to be "H" level or "L" level when a HOLD pin input is transited to the hold condition as shown in the diagram below. In case the HOLD pin transited to "L" level when SCK is "L" level, return the HOLD pin to "H" level at SCK being "L" level. In the same manner, in case the HOLD pin transited to "L" level when SCK is "H" level, return the HOLD pin to "H" level at SCK being "H" level. Arbitrary command operation is interrupted in hold status, SCK and SI inputs become do not care. And, SO becomes High-Z while reading command (RDSR, READ).  $\overline{CS}$  shall be set to "L" level during hold status.



#### ■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Ra	Unit	
raidilletei	Symbol	Min	Max	Offic
Power supply voltage*	$V_{DD}$	- 0.5	+ 4.0	V
Input voltage*	Vin	- 0.5	$V_{DD} + 0.5 \ ( \le 4.0)$	V
Output voltage*	Vоит	- 0.5	$V_{DD} + 0.5 \ ( \le 4.0)$	V
Operation ambient temperature	TA	<b>- 40</b>	+ 85	°C
Storage temperature	Tstg	<b>– 55</b>	+ 125	°C

<sup>\*:</sup>These parameters are based on the condition that Vss is 0 V.

WARNING: Semiconductor devices may be permanently damaged by application of stress (including, without limitation, voltage, current or temperature) in excess of absolute maximum ratings.

Do not exceed any of these ratings.

#### ■ RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol		Unit		
Farameter	Symbol	Min	Тур	Max	Offic
Power supply voltage*1	V <sub>DD</sub>	1.6	_	3.6	V
Operation ambient temperature*2	TA	- 40	_	+ 85	°C

<sup>\*1:</sup> These parameters are based on the condition that Vss is 0 V.

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated under these conditions.

Any use of semiconductor devices will be under their recommended operating condition. Operation under any conditions other than these conditions may adversely affect reliability of device and could result in device failure.

No warranty is made with respect to any use, operating conditions or combinations not represented on this data sheet. If you are considering application under any conditions other than listed herein, please contact sales representatives beforehand.

<sup>\*2:</sup> Ambient temperature when only this device is working. Please consider it to be the almost same as the package surface temperature.

## **■ ELECTRICAL CHARACTERISTICS**

## 1. DC Characteristics

(within recommended operating conditions)

Doromotor	Symbol	Condition		Unit			
Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Input leakage current	lu	$\overline{\text{CS}}, \overline{\text{WP}}, \text{SCK, SI,} \ \overline{\text{HOLD}} = 0 \text{ V to VDD}$	_	_	1	μА	
Output leakage current	Ito	SO = 0 V to V <sub>DD</sub>	_	_	1	μΑ	
Operating power supply	IDDR (60)	SCK = 5 MHz, $T_A=0$ °C to 60 °C, $1.6V \le V_{DD} \le 2.0V$	_	0.15	0.3	- mA	
current (Read)	IDDR (85)	SCK = 10 MHz, $T_{A}$ = $-40$ °C to 85 °C, $1.6V \le V_{DD} \le 3.6V$	_	_	0.7		
Operating power supply	IDDW (60)	$\label{eq:SCK} \begin{split} \text{SCK} &= \text{twc}, \\ \text{T}_{\text{A}} &= 0 ^{\circ}\text{C to } 60 ^{\circ}\text{C}, \\ 1.6\text{V} &\leq \text{V}_{\text{DD}} \leq 2.0\text{V} \end{split}$		1.5	_	mA	
current (Write)	IDDW (85)	$\label{eq:SCK} \begin{split} \text{SCK} &= \text{twc}, \\ \text{T}_{\text{A}} &= -40 ^{\circ}\text{C to } 85 ^{\circ}\text{C}, \\ 1.6\text{V} &\leq \text{V}_{\text{DD}} \leq 3.6\text{V} \end{split}$			2.5	111/	
Standby current	Isa	$SCK = SI = \overline{CS} = V_{DD}$	_	60	500	μΑ	
Sleep current	lzz	$\overline{\text{CS}} = \text{V}_{\text{DD}}$ All inputs Vss or V <sub>DD</sub> V <sub>DD</sub> =3.6V, T <sub>A</sub> =85 °C	_	6	8	μА	
Sleep current	Izz	$\overline{\text{CS}} = \text{V}_{\text{DD}}$ All inputs Vss or V <sub>DD</sub> V <sub>DD</sub> =1.45V, T <sub>A</sub> =60 °C			6	μΑ	
Input high voltage	ViH	V <sub>DD</sub> = 1.6 V to 3.6 V	$V_{DD} \times 0.7$		V <sub>DD</sub> + 0.5	V	
Input low voltage	V <sub>IL</sub> V <sub>DD</sub> = 1.6 V to 3.6 V		- 0.5		$V_{DD} \times 0.3$	V	
Output high voltage	Vон	$\begin{array}{l} I_{OH} = \ -1.5 \ mA \ @V_{DD} \geq 1.8 \ V \\ I_{OH} = \ -1.2 \ mA \ @V_{DD} < 1.8 \ V \\ \end{array}$	$V_{DD} \times 0.8$	_		V	
Output low voltage	Vol	$I_{OL} = 1.5 \text{ mA } @V_{DD} \ge 1.8 \text{ V} \\ I_{OL} = 1.2 \text{ mA } @V_{DD} < 1.8 \text{ V}$	_	_	V <sub>DD</sub> × 0.2	V	

## 2. AC Characteristics

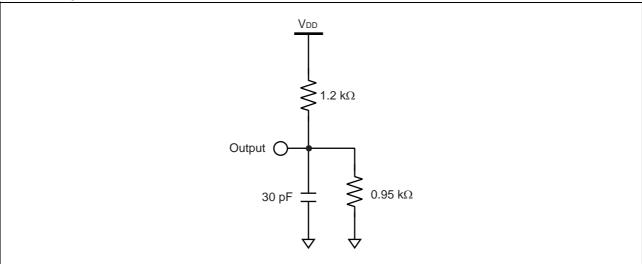
Davamatar	Symbol	Value			l lm!4	Candition
Parameter	Symbol	Min	Тур	Max	Unit	Condition
SCK clock frequency	fск	0		10	MHz	
Clock high time	<b>t</b> cH	40	_	_	ns	
Clock low time	<b>t</b> cL	40	_	_	ns	
Chip select set up time	tcsuн	30	_	_	20	CS rising to SCK rising
Chip select set up time	<b>t</b> csuL	30	_	_	ns	CS falling to SCK rising
	tсsнн	30	_	_		SCK rising to CS falling
Chip select hold time	<b>t</b> cshL	30	_	_	ns	SCK rising to CS rising
	<b>t</b> csH	30	_	_		SCK falling to CS rising
Output disable time	tod			30	ns	
Output active time	tolz	0	_	_	ns	
Output data valid time	todv		_	35	ns	
Output hold time	tон	0	_	_	ns	
Deselect time	t⊳	100	_	_	ns	
Data rising time	<b>t</b> R		_	50	ns	
Data falling time	t⊧		_	50	ns	
Data set up time	<b>t</b> su	20	_	_	ns	
Data hold time	tн	20	_	_	ns	
HOLD set uptime	<b>t</b> HS	10	_	_	ns	
HOLD hold time	tнн	10			ns	
HOLD output floating time	<b>t</b> HZ		_	30	ns	
HOLD output active time	<b>t</b> LZ			30	ns	
Write cycle time	<b>t</b> wc		5000	10000	μS	@100% data turn over
Recovery time from SLEEP mode	trec		700	1000	μS	
CS pulse width at SLEEP mode exit	tcswL	100	_	_	ns	

## **AC Test Condition**

Power supply voltage : 1.6 V to 3.6 V Operation ambient temperature : -40 °C to +85 °C Input voltage magnitude :  $V_{DD} \times 0.7 \le V_{IH} \le V_{DD}$ 

 $0 \leq V_{\text{IL}} \leq V_{\text{DD}} \times 0.3$ 

## **AC Load Equivalent Circuit**

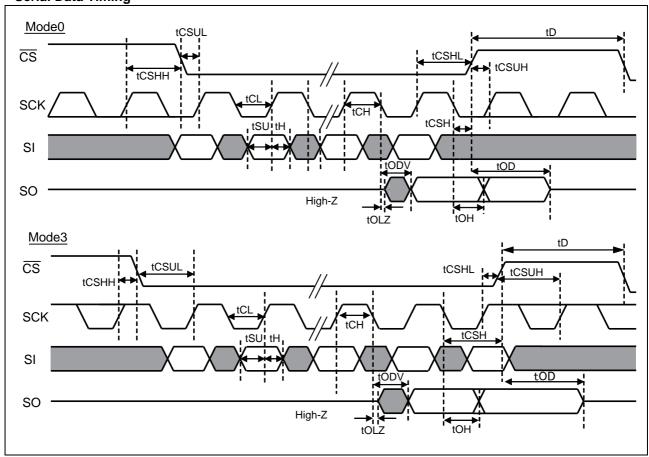


## 3. Pin Capacitance

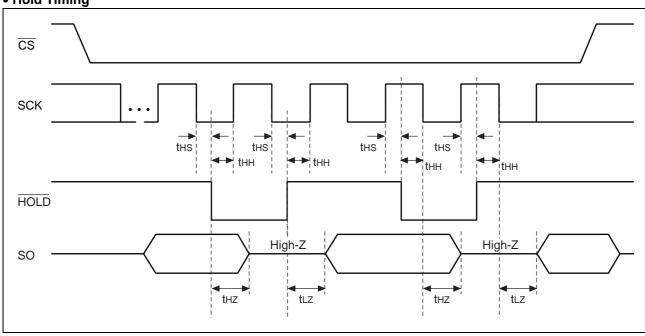
Parameter	Symbol	Condition	Va	Unit	
raiametei	Symbol	Condition	Min	Max	Oille
Output capacitance	Со	$V_{DD} = V_{IN} = V_{OUT} = 0 V,$	_	6	pF
Input capacitance	Сі	f = 1 MHz, T <sub>A</sub> = +25 °C	_	6	pF

## **■ TIMING DIAGRAM**

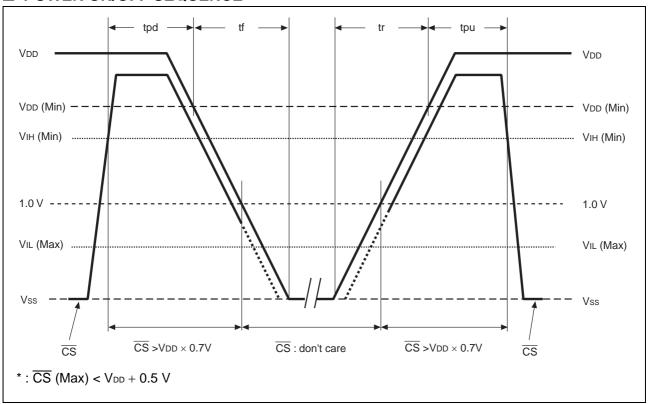
## • Serial Data Timing



## • Hold Timing



## **■ POWER ON/OFF SEQUENCE**



Parameter	Symbol	Va	Unit	
Farameter	Symbol		Max	Offic
CS level hold time at power OFF	tpd	10	_	ms
CS level hold time at power ON	tpu	1	_	ms
Power supply rising time	tr	50	_	μs/V
Power supply falling time	tf	100	_	μs/V

If the device does not operate within the specified conditions of read cycle, write cycle or power on/off sequence, memory data can not be guaranteed.

## **■ ReRAM CHARACTERISTICS**

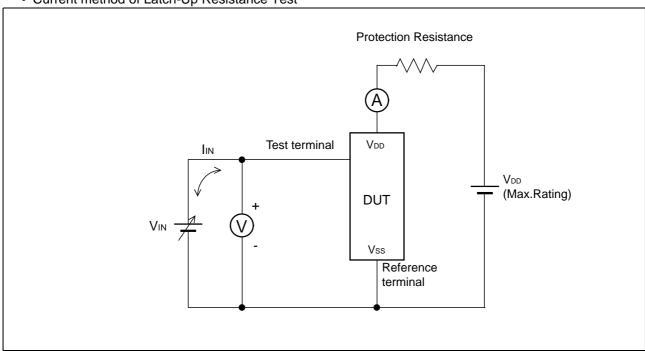
Parameter	Value		Unit	Remarks	
	Min	Max	Oilit	Kemarks	
Write Endurance	$1 \times 10^6$		Times/4bytes*	Operation Ambient Temperature T <sub>A</sub> = +85 °C	
Data Retention	10		Years	Operation Ambient Temperature T <sub>A</sub> = +85 °C	
Data register size		256	byte		

<sup>\*: 4</sup> bytes are selected by A1 to A0.

### **■ ESD AND LATCH-UP**

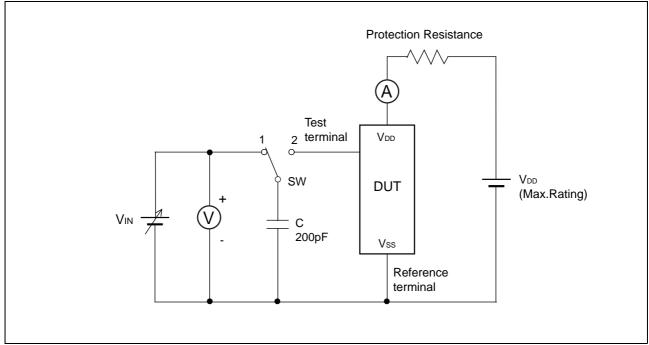
Test	DUT	Value	
ESD HBM (Human Body Model) JESD22-A114 compliant		≥  2000 V	
ESD CDM (Charged Device Model) JESD22-C101 compliant	MB85AS8MTPF	≥  500 V	
Latch-Up (I-test) JESD78 compliant		≥  100 mA	
Latch-Up (V <sub>supply</sub> overvoltage test) JESD78 compliant		_	
Latch-Up (Current Method) Proprietary method		_	
Latch-Up (C-V Method) Proprietary method		_	

• Current method of Latch-Up Resistance Test



Note: The voltage  $V_{IN}$  is increased gradually and the current  $I_{IN}$  of 300 mA at maximum shall flow. Confirm the latch up does not occur under  $I_{IN} = \pm 300$  mA. In case the specific requirement is specified for I/O and  $I_{IN}$  cannot be 300 mA, the voltage shall be increased to the level that meets the specific requirement.

• C-V method of Latch-Up Resistance Test



Note: Charge voltage alternately switching 1 and 2 approximately 2 sec interval. This switching process is considered as one cycle. Repeat this process 5 times. However, if the latch-up condition occurs before completing 5times, this test must be stopped immediately.

# ■ MB85AS8MTPF (8-pin plastic SOP) REFLOW CONDITIONS AND FLOOR LIFE [JEDEC MSL]: Moisture Sensitivity Level 3 (ISP/JEDEC J-STD-020D)

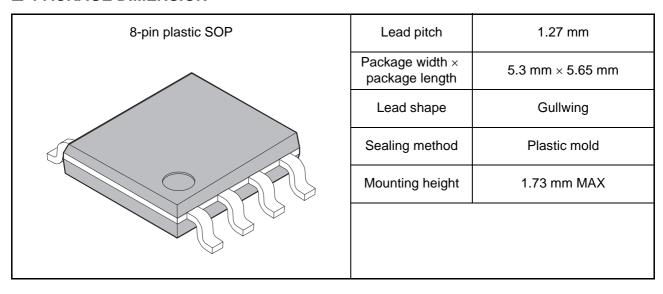
## **■ CURRENT STATUS ON CONTAINED RESTRICTED SUBSTANCES**

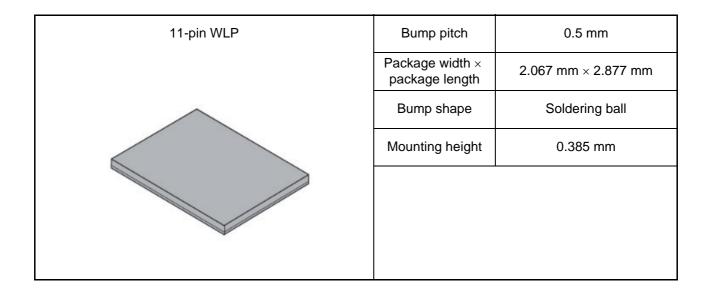
This product complies with the regulations of REACH Regulations, EU RoHS Directive and China RoHS.

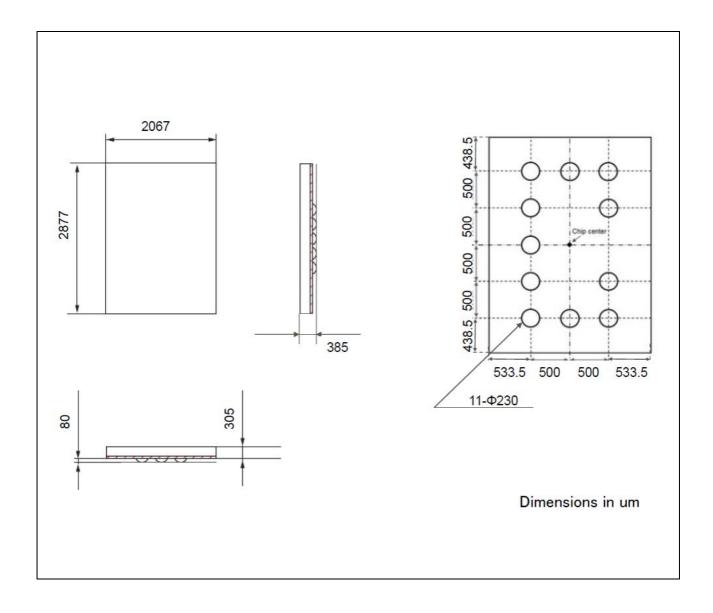
## **■** ORDERING INFORMATION

Part number	Package	Shipping form	Minimum shipping quantity	
MB85AS8MTPW-G-KBAERE1	11-pin WLP Type-A	Embossed Carrier Tape	10,000	
MB85AS8MTPW-G-KBBERE1	11-pin WLP Type-B	Embossed Carrier Tape	10,000	
MB85AS8MTPF-G-KBERE1	SOP 8-pin	Embossed Carrier Tape	TBD	

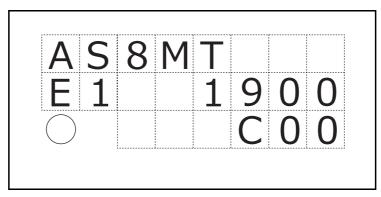
## **■ PACKAGE DIMENSION**







## ■ MARKING (11-pin WLP)

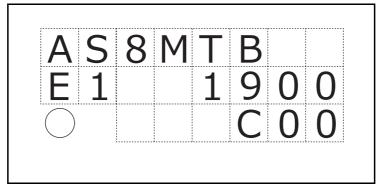


11-pin WLP Type A

AS8MT : Product name E1 : Fixed code

1900 : Year and Week code

C00 : C (Fixed code)+00 (Trace code)



11-pin WLP Type B

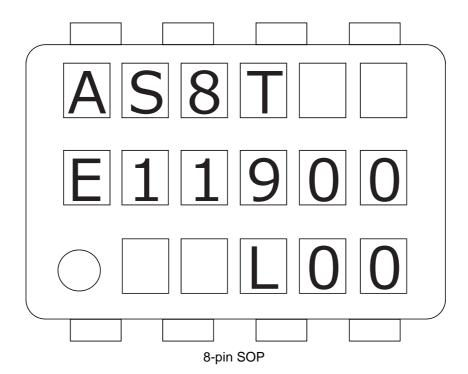
AS8MTB: Product name+B (Fixed code)

E1 : Fixed code

1900 : Year and Week code

C00 : C (Fixed code)+00 (Trace code)

## ■ MARKING (8-pin SOP)



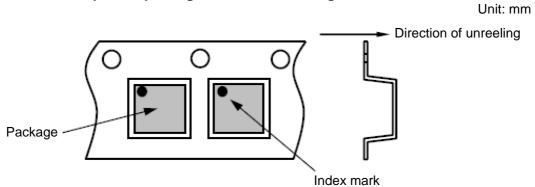
AS8MT : Product name E1 : Fixed code

1900 : Year and Week code

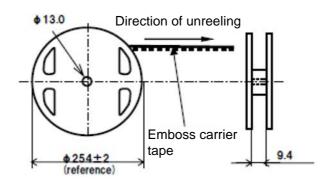
L00 : L (Fixed code)+00 (Trace code)

## **■ PACKING FIGURE**

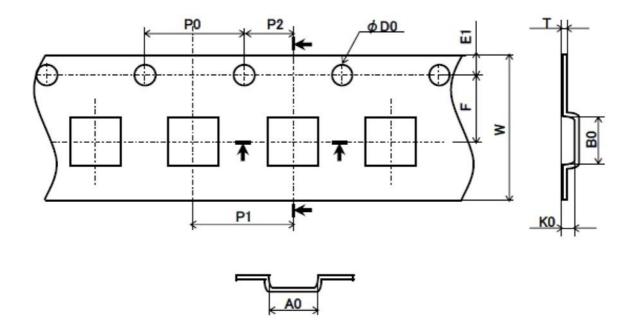
## 1. Emboss carrier tape and package direction of storage



## 2. Reel



## **■ EMBOSS CARRIER TAPE DRAWING**



Unit: mm

Dimensions of Emboss carrier tape									
W	A0	В0	K0	Т	P0				
8.0 ± 0.3	$2.25 \pm 0.05$	$3.25 \pm 0.05$	$0.60 \pm 0.05$	$0.25\pm0.05$	4 ± 0.1				
P1	P2	φ <b>D</b> 0	E1	F					
4 ± 0.1	2 ± 0.05	1.5 + 0.1 - 0	1.75 ± 0.1	3.5 ± 0.05					

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